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#### What is "[Embedded - Microcontrollers](#)"?

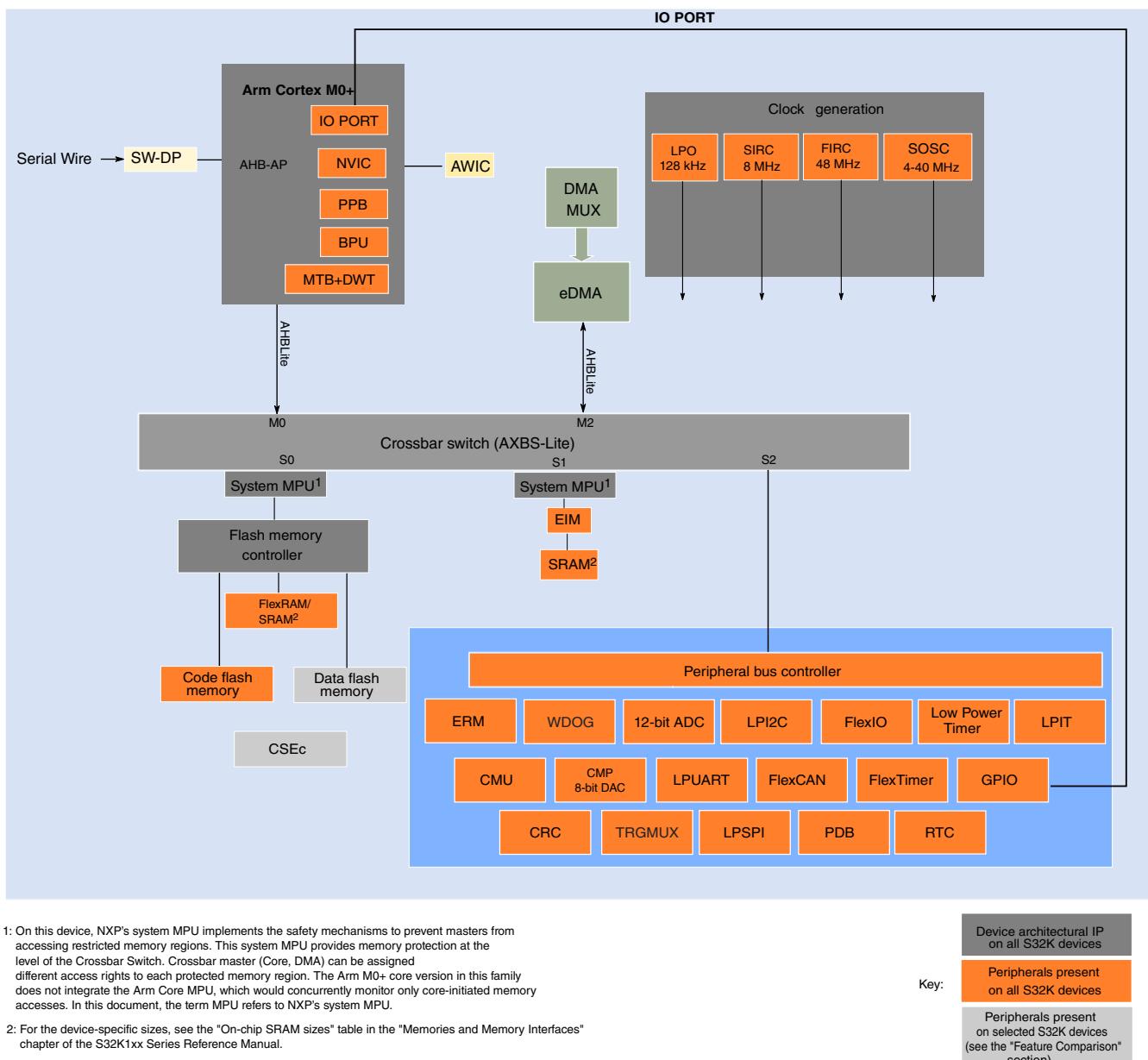
"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

#### Applications of "[Embedded - Microcontrollers](#)"

##### Details

Product Status	Active
Core Processor	ARM® Cortex®-M4F
Core Size	32-Bit Single-Core
Speed	80MHz
Connectivity	CANbus, Ethernet, FlexIO, I²C, LINbus, SPI, UART/USART
Peripherals	I²S, POR, PWM, WDT
Number of I/O	128
Program Memory Size	2MB (2M x 8)
Program Memory Type	FLASH
EEPROM Size	4K x 8
RAM Size	256K x 8
Voltage - Supply (Vcc/Vdd)	2.7V ~ 5.5V
Data Converters	A/D 32x12b SAR; D/A 1x8b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	144-LQFP
Supplier Device Package	144-LQFP (20x20)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/nxp-semiconductors/fs32k148hrt0vlqt">https://www.e-xfl.com/product-detail/nxp-semiconductors/fs32k148hrt0vlqt</a>

- Communications interfaces
  - Up to three Low Power Universal Asynchronous Receiver/Transmitter (LPUART/LIN) modules with DMA support and low power availability
  - Up to three Low Power Serial Peripheral Interface (LPSPI) modules with DMA support and low power availability
  - Up to two Low Power Inter-Integrated Circuit (LPI2C) modules with DMA support and low power availability
  - Up to three FlexCAN modules (with optional CAN-FD support)
  - FlexIO module for emulation of communication protocols and peripherals (UART, I2C, SPI, I2S, LIN, PWM, etc).
  - Up to one 10/100Mbps Ethernet with IEEE1588 support and two Synchronous Audio Interface (SAI) modules.
- Safety and Security
  - Cryptographic Services Engine (CSEc) implements a comprehensive set of cryptographic functions as described in the SHE (Secure Hardware Extension) Functional Specification. Note: CSEc (Security) or EEPROM writes/erase will trigger error flags in HSRUN mode (112 MHz) because this use case is not allowed to execute simultaneously. The device will need to switch to RUN mode (80 MHz) to execute CSEc (Security) or EEPROM writes/erase.
  - 128-bit Unique Identification (ID) number
  - Error-Correcting Code (ECC) on flash and SRAM memories
  - System Memory Protection Unit (System MPU)
  - Cyclic Redundancy Check (CRC) module
  - Internal watchdog (WDOG)
  - External Watchdog monitor (EWM) module
- Timing and control
  - Up to eight independent 16-bit FlexTimers (FTM) modules, offering up to 64 standard channels (IC/OC/PWM)
  - One 16-bit Low Power Timer (LPTMR) with flexible wake up control
  - Two Programmable Delay Blocks (PDB) with flexible trigger system
  - One 32-bit Low Power Interrupt Timer (LPIT) with 4 channels
  - 32-bit Real Time Counter (RTC)
- Package
  - 32-pin QFN, 48-pin LQFP, 64-pin LQFP, 100-pin LQFP, 100-pin MAPBGA, 144-pin LQFP, 176-pin LQFP package options
- 16 channel DMA with up to 63 request sources using DMAMUX



**Figure 2. High-level architecture diagram for the S32K11x family**

## 2 Feature comparison

The following figure summarizes the memory, peripherals and packaging options for the S32K1xx devices. All devices which share a common package are pin-to-pin compatible.

### NOTE

Availability of peripherals depends on the pin availability in a particular package. For more information see *IO Signal*

The following table shows the power consumption targets for S32K148 in various mode of operations measure at 3.3 V.

**Table 9. Power consumption at 3.3 V**

Chip/Device	Ambient Temperature (°C)		RUN@80 MHz (mA)		HSRUN@112 MHz (mA) <sup>1</sup>	
			Peripherals enabled + QSPI	Peripherals enabled + ENET + SAI	Peripherals enabled + QSPI	Peripherals enabled + ENET + SAI
S32K148	25	Typ	67.3	79.1	89.8	105.5
	85	Typ	67.4	79.2	95.6	105.9
		Max	82.5	88.2	109.7	117.4
	105	Typ	68.0	79.8	96.6	106.7
		Max	80.3	89.1	109.0	119.0
	125	Max	83.5	94.7	NA	

1. HSRUN mode must not be used at 125°C. Max ambient temperature for HSRUN mode is 105°C.

## 4.8 ESD handling ratings

Symbol	Description	Min.	Max.	Unit	Notes
V <sub>HBM</sub>	Electrostatic discharge voltage, human body model	- 4000	4000	V	<sup>1</sup>
V <sub>CDM</sub>	Electrostatic discharge voltage, charged-device model				<sup>2</sup>
	All pins except the corner pins	- 500	500	V	
	Corner pins only	- 750	750	V	
I <sub>LAT</sub>	Latch-up current at ambient temperature of 125 °C	- 100	100	mA	<sup>3</sup>

1. Determined according to JEDEC Standard JESD22-A114, *Electrostatic Discharge (ESD) Sensitivity Testing Human Body Model (HBM)*.
2. Determined according to JEDEC Standard JESD22-C101, *Field-Induced Charged-Device Model Test Method for Electrostatic-Discharge-Withstand Thresholds of Microelectronic Components*.
3. Determined according to JEDEC Standard JESD78, *IC Latch-Up Test*.

## 4.9 EMC radiated emissions operating behaviors

EMC measurements to IC-level IEC standards are available from NXP on request.

**Table 16. Device clock specifications 1 (continued)**

Symbol	Description	Min.	Max.	Unit
$f_{FLASH}$	Flash clock	—	24	MHz
Normal run mode (S32K14x series) <sup>3</sup>				
$f_{SYS}$	System and core clock	—	80	MHz
$f_{BUS}$	Bus clock	—	40 <sup>4</sup>	MHz
$f_{FLASH}$	Flash clock	—	26.67	MHz
VLPR mode <sup>5</sup>				
$f_{SYS}$	System and core clock	—	4	MHz
$f_{BUS}$	Bus clock	—	4	MHz
$f_{FLASH}$	Flash clock	—	1	MHz
$f_{ERCLK}$	External reference clock	—	16	MHz

1. Refer to the section [Feature comparison](#) for the availability of modes and other specifications.
2. Only available on some devices. See section [Feature comparison](#).
3. With SPLL as system clock source.
4. 48 MHz when  $f_{SYS}$  is 48 MHz
5. The frequency limitations in VLPR mode here override any frequency specification listed in the timing specification for any other module.

## 6 Peripheral operating requirements and behaviors

### 6.1 System modules

There are no electrical specifications necessary for the device's system modules.

### 6.2 Clock interface modules

#### 6.2.1 External System Oscillator electrical specifications

**Table 17. External System Oscillator electrical specifications  
(continued)**

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
	High-gain mode (HGO=1)	—	1	—	MΩ	
R <sub>S</sub>	Series resistor					3
	Low-gain mode (HGO=0)	—	0	—	kΩ	
	High-gain mode (HGO=1)	—	0	—	kΩ	
V <sub>pp</sub>	Peak-to-peak amplitude of oscillation (oscillator mode)					3
	Low-gain mode (HGO=0)	—	1.0	—	V	
	High-gain mode (HGO=1)	—	3.3	—	V	

1. Crystal oscillator circuit provides stable oscillations when  $g_{mXOSC} > 5 * gm\_crit$ . The  $gm\_crit$  is defined as:

$$gm\_crit = 4 * ESR * (2\pi F)^2 * (C_0 + C_L)^2$$

where:

- $g_{mXOSC}$  is the transconductance of the internal oscillator circuit
- ESR is the equivalent series resistance of the external crystal
- F is the external crystal oscillation frequency
- $C_0$  is the shunt capacitance of the external crystal
- $C_L$  is the external crystal total load capacitance.  $C_L = C_s + [C_1 * C_2 / (C_1 + C_2)]$
- $C_s$  is stray or parasitic capacitance on the pin due to any PCB traces
- $C_1, C_2$  external load capacitances on EXTAL and XTAL pins

See manufacture datasheet for external crystal component values

2.
  - When low-gain is selected, internal  $R_F$  will be selected and external  $R_F$  should not be attached.
  - When high-gain is selected, external  $R_F$  (1 M Ohm) needs to be connected for proper operation of the crystal. For external resistor, up to 5% tolerance is allowed.
3. The EXTAL and XTAL pins should only be connected to required oscillator components and must not be connected to any other devices.

## 6.2.2 External System Oscillator frequency specifications

## 6.2.3 System Clock Generation (SCG) specifications

### 6.2.3.1 Fast internal RC Oscillator (FIRC) electrical specifications

Table 19. Fast internal RC Oscillator electrical specifications

Symbol	Parameter <sup>1</sup>	Value			Unit
		Min.	Typ.	Max.	
$F_{\text{FIRC}}$	FIRC target frequency	—	48	—	MHz
$\Delta F$	Frequency deviation across process, voltage, and temperature < 105°C	—	$\pm 0.5$	$\pm 1$	% $F_{\text{FIRC}}$
$\Delta F_{125}$	Frequency deviation across process, voltage, and temperature < 125°C	—	$\pm 0.5$	$\pm 1.1$	% $F_{\text{FIRC}}$
$T_{\text{Startup}}$	Startup time	—	3.4	5	$\mu\text{s}^2$
$T_{\text{JIT}}^{\text{3}}$	Cycle-to-Cycle jitter	—	300	500	ps
$T_{\text{JIT}}^{\text{3}}$	Long term jitter over 1000 cycles	—	0.04	0.1	% $F_{\text{FIRC}}$

- With FIRC regulator enable
- Startup time is defined as the time between clock enablement and clock availability for system use.
- FIRC as system clock

### NOTE

Fast internal RC Oscillator is compliant with CAN and LIN standards.

### 6.2.3.2 Slow internal RC oscillator (SIRC) electrical specifications

Table 20. Slow internal RC oscillator (SIRC) electrical specifications

Symbol	Parameter	Value			Unit
		Min.	Typ.	Max.	
$F_{\text{SIRC}}$	SIRC target frequency	—	8	—	MHz
$\Delta F$	Frequency deviation across process, voltage, and temperature < 105°C	—	—	$\pm 3$	% $F_{\text{SIRC}}$
$\Delta F_{125}$	Frequency deviation across process, voltage, and temperature < 125°C	—	—	$\pm 3.3$	% $F_{\text{SIRC}}$
$T_{\text{Startup}}$	Startup time	—	9	12.5	$\mu\text{s}^1$

- Startup time is defined as the time between clock enablement and clock availability for system use.

Table 26. QuadSPI electrical specifications (continued)

FLASH PORT	Sym	Unit	FLASH A												FLASH B					
			RUN <sup>1</sup>						HSRUN <sup>1</sup>						RUN/HSRUN <sup>2</sup>					
			SDR						SDR						SDR			DDR <sup>3</sup>		
			Internal Sampling			Internal DQS			Internal Sampling			Internal DQS			Internal Sampling			External DQS		
			N1		PAD Loopback		Internal Loopback		N1		PAD Loopback		Internal Loopback		N1		External DQS			
			Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max
SCK Duty Cycle	t <sub>SDC</sub>	ns	tSCK2 + 2.5		tSCK2 - 2.5		tSCK2 + 1.5		tSCK2 - 1.5		tSCK2 + 0.750		tSCK2 + 1.5		tSCK2 - 1.5		tSCK2 + 1.5		tSCK2 - 1.5	
Data Input Setup Time	t <sub>SI</sub>	ns	15	-	2.5	-	10	-	14	-	1.6	-	6	-	25	-	2	-	-	-
Data Input Hold Time	t <sub>HI</sub>	ns	0	-	1	-	1	-	0	-	1	-	1	-	0	-	20	-	-	-
Data Output Valid Time	t <sub>OV</sub>	ns	-	4.5	-	4.5	-	4.5	-	-	4	-	4	-	4	-	-	10	-	10
Data Output In-Valid Time	t <sub>IV</sub>	ns	-	5	-	5	-	5	-	5	-	5	-	3 <sup>5</sup>	-	5	-	5	-	5
CS to SCK Time <sup>6</sup>	t <sub>cssck</sub>	ns	5	-	5	-	5	-	5	-	5	-	5	-	5	-	10	-	10	-
SCK to CS Time <sup>7</sup>	t <sub>sckcs</sub>	ns	5	-	5	-	5	-	5	-	5	-	5	-	5	-	5	-	5	-
Output Load		pf	25		25		25		25		25		25		25		25		25	

1. See Reference Manual for details on mode settings
2. See Reference Manual for details on mode settings
3. Valid for HyperRAM only
4. RWDS(External DQS CLK) frequency
5. For operating frequency  $\leq 64$  Mhz, Output invalid time is 5 ns.
6. Program register value QuadSPI\_FLSHCR[TCSS] = 4'h2
7. Program register value QuadSPI\_FLSHCR[TCSH] = 4'h1

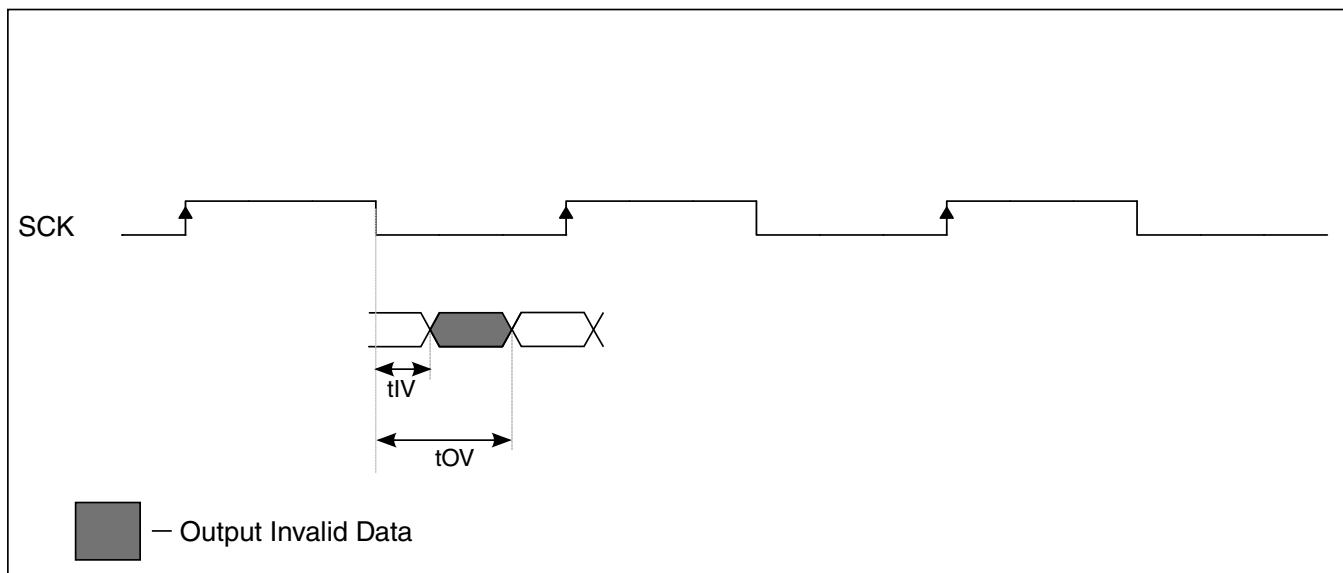


Figure 12. QuadSPI output timing (HyperRAM mode) diagram

## 6.4 Analog modules

### 6.4.1 ADC electrical specifications

#### 6.4.1.1 12-bit ADC operating conditions

Table 27. 12-bit ADC operating conditions

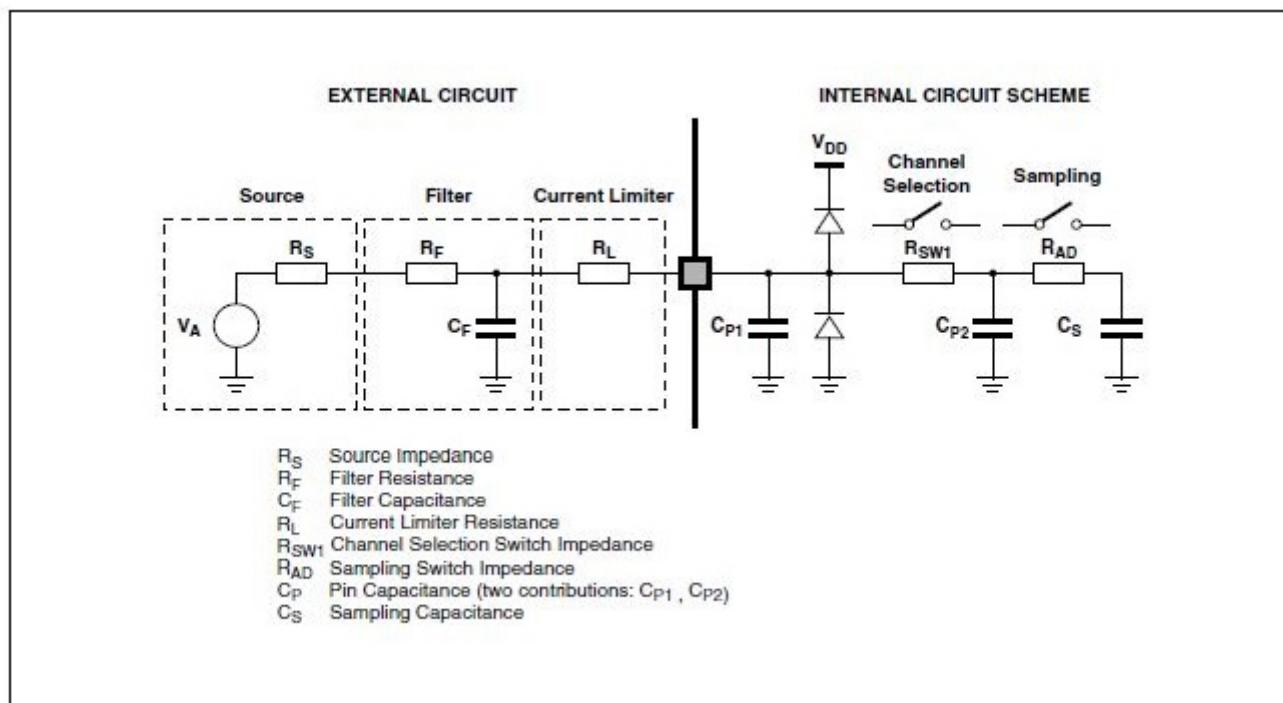
Symbol	Description	Conditions	Min.	Typ. <sup>1</sup>	Max.	Unit	Notes
$V_{REFH}$	ADC reference voltage high		See Voltage and current operating requirements for values	$V_{DDA}$	See Voltage and current operating requirements for values	V	<a href="#">2</a>
$V_{REFL}$	ADC reference voltage low		See Voltage and current operating requirements for values	0	See Voltage and current operating requirements for values	mV	<a href="#">2</a>
$V_{ADIN}$	Input voltage		$V_{REFL}$	—	$V_{REFH}$	V	
$R_S$	Source impedance	$f_{ADCK} < 4 \text{ MHz}$	—	—	5	$k\Omega$	
$R_{SW1}$	Channel Selection Switch Impedance		—	0.75	1.2	$k\Omega$	
$R_{AD}$	Sampling Switch Impedance		—	2	5	$k\Omega$	
$C_{P1}$	Pin Capacitance		—	10	—	pF	
$C_{P2}$	Analog Bus Capacitance		—	—	4	pF	
$C_S$	Sampling capacitance		—	4	5	pF	

Table continues on the next page...

**Table 27. 12-bit ADC operating conditions (continued)**

Symbol	Description	Conditions	Min.	Typ. <sup>1</sup>	Max.	Unit	Notes
$f_{ADCK}$	ADC conversion clock frequency	Normal usage	2	40	50	MHz	<a href="#">3, 4</a>
$f_{CONV}$	ADC conversion frequency	No ADC hardware averaging. <sup>5</sup> Continuous conversions enabled, subsequent conversion time	46.4	928	1160	Ksps	<a href="#">6, 7</a>
		ADC hardware averaging set to 32. <sup>5</sup> Continuous conversions enabled, subsequent conversion time	1.45	29	36.25	Ksps	<a href="#">6, 7</a>

1. Typical values assume  $V_{DDA} = 5$  V, Temp = 25 °C,  $f_{ADCK} = 40$  MHz,  $R_{AS}=20 \Omega$ , and  $C_{AS}=10$  nF unless otherwise stated. Typical values are for reference only, and are not tested in production.
2. For packages without dedicated  $V_{REFH}$  and  $V_{REFL}$  pins,  $V_{REFH}$  is internally tied to  $V_{DDA}$ , and  $V_{REFL}$  is internally tied to  $V_{SS}$ . To get maximum performance, reference supply quality should be better than SAR ADC. See application note [AN5032](#) for details.
3. Clock and compare cycle need to be set according to the guidelines mentioned in the *Reference Manual*.
4. ADC conversion will become less reliable above maximum frequency.
5. When using ADC hardware averaging, see the *Reference Manual* to determine the most appropriate setting for AVGS.
6. Numbers based on the minimum sampling time of 275 ns.
7. For guidelines and examples of conversion rate calculation, see the *Reference Manual* section 'Calibration function'

**Figure 13. ADC input impedance equivalency diagram**

**Table 32. LPSPI electrical specifications<sup>1</sup>**

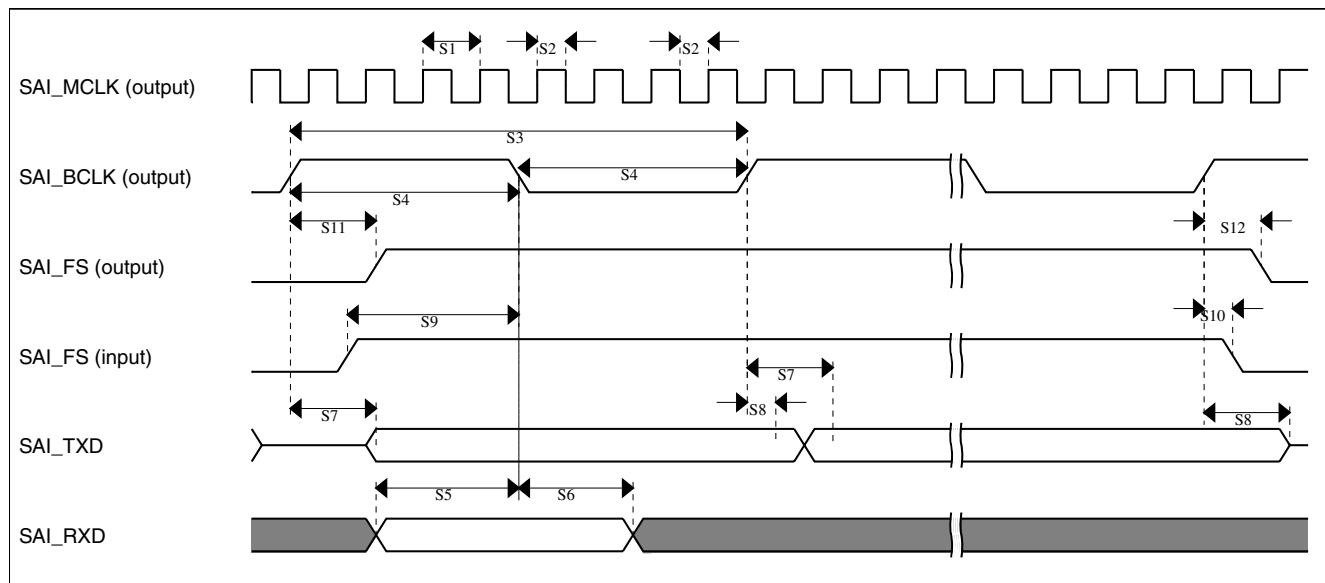
Num	Symbol	Description	Conditions	Run Mode <sup>2</sup>				HSRUN Mode <sup>2</sup>				VLPR Mode				Unit	
				5.0 V IO		3.3 V IO		5.0 V IO		3.3 V IO		5.0 V IO		3.3 V IO			
				Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.		
	$f_{\text{periph}}^{3,4}$	Peripheral Frequency	Slave	-	40	-	40	-	56	-	56	-	4	-	4	MHz	
			Master	-	40	-	40	-	56	-	56	-	4	-	4		
			Master Loopback <sup>5</sup>	-	40	-	48	-	48	-	48	-	4	-	4		
			Master Loopback(slow) <sup>6</sup>	-	48	-	48	-	48	-	48	-	4	-	4		
1	$f_{\text{op}}$	Frequency of operation	Slave	-	10	-	10	-	14	-	14 <sup>7</sup>	-	2	-	2	MHz	
			Master	-	10	-	10	-	14	-	14 <sup>7</sup>	-	2	-	2		
			Master Loopback <sup>5</sup>	-	20	-	12	-	24	-	12	-	2	-	2		
			Master Loopback(slow) <sup>6</sup>	-	12	-	12	-	12	-	12	-	2	-	2		
2	$t_{\text{SPSCK}}$	SPSCK period	Slave	100	-	100	-	72	-	72	-	500	-	500	-	ns	
			Master	100	-	100	-	72	-	72	-	500	-	500	-		
			Master Loopback <sup>5</sup>	50	-	83	-	42	-	83	-	500	-	500	-		
			Master Loopback(slow) <sup>6</sup>	83	-	83	-	83	-	83	-	500	-	500	-		
3	$t_{\text{Lead}}^8$	Enable lead time (PCS to SPSCK delay)	Slave	-	-	-	-	-	-	-	-	-	-	-	-	ns	
			Master	-	-	-	-	-	-	-	-	-	-	-	-		
			Master Loopback <sup>5</sup>	(PCSSCK+1)* <sub>t_periph-25</sub>				(PCSSCK+1)* <sub>t_periph-25</sub>				(PCSSCK+1)* <sub>t_periph-25</sub>					
			Master Loopback(slow) <sup>6</sup>	(PCSSCK+1)* <sub>t_periph-25</sub>				(PCSSCK+1)* <sub>t_periph-25</sub>				(PCSSCK+1)* <sub>t_periph-25</sub>					

Table continues on the next page...

**Table 32. LPSPI electrical specifications<sup>1</sup> (continued)**

Num	Symbol	Description	Conditions	Run Mode <sup>2</sup>				HSRUN Mode <sup>2</sup>				VLPR Mode				Unit	Communication modules		
				5.0 V IO		3.3 V IO		5.0 V IO		3.3 V IO		5.0 V IO		3.3 V IO					
				Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.				
4	t <sub>Lag</sub> <sup>9</sup>	Enable lag time (After SPSCK delay)	Slave	-	-	-	-	-	-	-	-	-	-	-	-	ns	Communication modules		
			Master	-	-	-	-	-	-	-	-	-	-	-	-				
			Master Loopback <sup>5</sup>	-	-	-	-	-	-	-	-	-	-	-	-				
			Master Loopback(slow) <sup>6</sup>	-	-	-	-	-	-	-	-	-	-	-	-				
5	t <sub>WSPSCK</sub> <sup>10</sup>	Clock(SPSCK) high or low time (SPSCK duty cycle)	Slave	-	-	-	-	-	-	-	-	-	-	-	-	ns	Communication modules		
			Master	-	-	-	-	-	-	-	-	-	-	-	-				
			Master Loopback <sup>5</sup>	-	-	-	-	-	-	-	-	-	-	-	-				
			Master Loopback(slow) <sup>6</sup>	-	-	-	-	-	-	-	-	-	-	-	-				
6	t <sub>SU</sub>	Data setup time(inputs)	Slave	3	-	5	-	3	-	5	-	18	-	18	-	ns	Communication modules		
			Master	29	-	38	-	26	-	37 <sup>11</sup> 32 <sup>12</sup>	-	72	-	78	-				
			Master Loopback <sup>5</sup>	7	-	8	-	5	-	7	-	20	-	20	-				
			Master Loopback(slow) <sup>6</sup>	8	-	10	-	7	-	9	-	20	-	20	-				
7	t <sub>Hl</sub>	Data hold time(inputs)	Slave	3	-	3	-	3	-	3	-	14	-	14	-	ns	Communication modules		
			Master	0	-	0	-	0	-	0	-	0	-	0	-				
			Master Loopback <sup>5</sup>	3	-	3	-	2	-	3	-	11	-	11	-				
			Master Loopback(slow) <sup>6</sup>	3	-	3	-	3	-	3	-	12	-	12	-				

Table continues on the next page...

**Figure 22. SAI Timing — Master modes****Table 34. Slave mode timing specifications**

Symbol	Description	Min.	Max.	Unit
—	Operating voltage	2.97	3.6	V
S13	SAI_BCLK cycle time (input)	80	—	ns
S14 <sup>1</sup>	SAI_BCLK pulse width high/low (input)	45%	55%	BCLK period
S15	SAI_RXD input setup before SAI_BCLK	8	—	ns
S16	SAI_RXD input hold after SAI_BCLK	2	—	ns
S17	SAI_BCLK to SAI_TxD output valid	—	28	ns
S18	SAI_BCLK to SAI_TxD output invalid	0	—	ns
S19	SAI_FS input setup before SAI_BCLK	8	—	ns
S20	SAI_FS input hold after SAI_BCLK	2	—	ns
S21	SAI_BCLK to SAI_FS output valid	—	28	ns
S22	SAI_BCLK to SAI_FS output invalid	0	—	ns

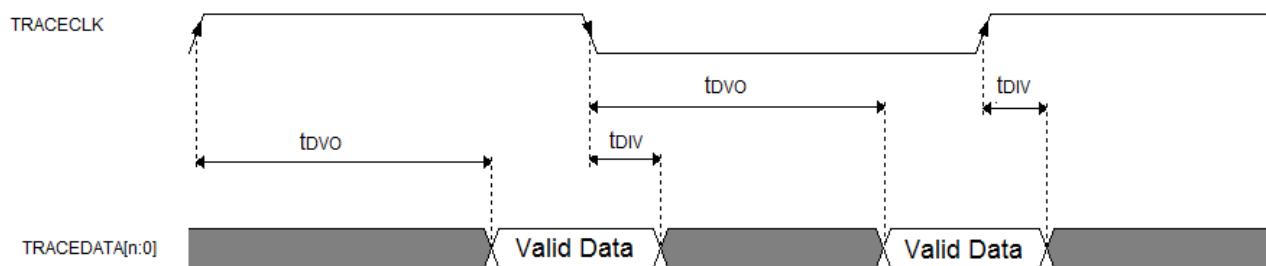
1. The slave mode parameters (S15 - S22) assume 50% duty cycle on SAI\_BCLK input. Any change in SAI\_BCLK duty cycle input must be taken care during the board design or by the master timing.

**Table 38. SWD electrical specifications**

Symbol	Description	Run Mode				HSRUN Mode				VLPR Mode				Unit	
		5.0 V IO		3.3 V IO		5.0 V IO		3.3 V IO		5.0 V IO		3.3 V IO			
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.		
S1	SWD_CLK frequency of operation	-	25	-	25	-	25	-	25	-	10	-	10	MHz	
S2	SWD_CLK cycle period	1/S1	-	1/S1	-	1/S1	-	1/S1	-	1/S1	-	1/S1	-	ns	
S3	SWD_CLK clock pulse width					S2/Z + 5	S2/Z - 5	S2/Z + 5	S2/Z - 5	S2/Z + 5	S2/Z - 5	S2/Z + 5	S2/Z - 5	ns	
S4	SWD_CLK rise and fall times	-	1	-	1	-	1	-	1	-	1	-	1	ns	
S9	SWD_DIO input data setup time to SWD_CLK rise	4	-	4	-	4	-	4	-	16	-	16	-	ns	
S10	SWD_DIO input data hold time after SWD_CLK rise	3	-	3	-	3	-	3	-	10	-	10	-	ns	
S11	SWD_CLK high to SWD_DIO data valid	-	28	-	38	-	28	-	38	-	70	-	77	ns	
S12	SWD_CLK high to SWD_DIO high-Z	-	28	-	38	-	28	-	38	-	70	-	77	ns	
S13	SWD_CLK high to SWD_DIO data invalid	0	-	0	-	0	-	0	-	0	-	0	-	ns	

**Table 39. Trace specifications (continued)**

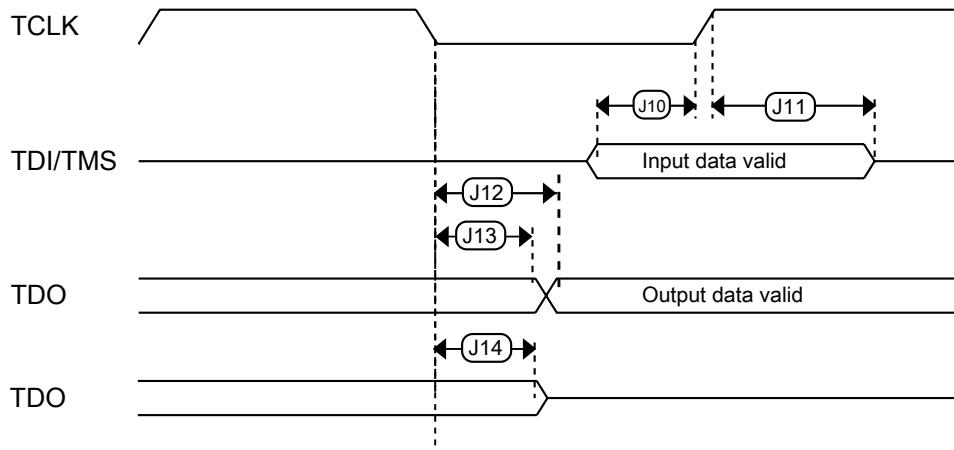
	Symbol	Description	RUN Mode			HSRUN Mode		VLPR Mode	Unit
Trace on fast pads	$f_{TRACE}$	Max Trace frequency	80	48	40	74.667	80	4	MHz
	$t_{DVO}$	Data Output Valid	4	4	4	4	4	20	ns
	$t_{DIV}$	Data Output Invalid	-2	-2	-2	-2	-2	-10	ns
Trace on slow pads	$f_{TRACE}$	Max Trace frequency	22.86	24	20	22.4	22.86	4	MHz
	$t_{DVO}$	Data Output Valid	8	8	8	8	8	20	ns
	$t_{DIV}$	Data Output Invalid	-4	-4	-4	-4	-4	-10	ns

**Figure 31. TRACE CLKOUT specifications**

### 6.6.3 JTAG electrical specifications

Table 40. JTAG electrical specifications

Symbol	Description	Run Mode				HSRUN Mode				VLPR Mode				Unit	
		5.0 V IO		3.3 V IO		5.0 V IO		3.3 V IO		5.0 V IO		3.3 V IO			
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.		
J1	TCLK frequency of operation													MHz	
	Boundary Scan	-	20	-	20	-	20	-	20	-	10	-	10		
	JTAG	-	20	-	20	-	20	-	20	-	10	-	10		
J2	TCLK cycle period	1/J1	-	1/J1	-	1/J1	-	1/J1	-	1/J1	-	1/J1	-	ns	
J3	TCLK clock pulse width													ns	
	Boundary Scan	5	5	5	5	5	5	5	5	5	5	5	5		
	JTAG	J2/Z + 5	J2/Z - 5	J2/Z + 5	J2/Z - 5	J2/Z + 5	J2/Z - 5	J2/Z + 5	J2/Z - 5	J2/Z + 5	J2/Z - 5	J2/Z + 5	J2/Z - 5		
J4	TCLK rise and fall times	-	1	-	1	-	1	-	1	-	1	-	1	ns	
J5	Boundary scan input data setup time to TCLK rise	5	-	5	-	5	-	5	-	5	-	15	-	ns	
J6	Boundary scan input data hold time after TCLK rise	5	-	5	-	5	-	5	-	5	-	8	-	ns	
J7	TCLK low to boundary scan output data valid	-	28	-	32	-	28	-	32	-	80	-	80	ns	
J8	TCLK low to boundary scan output data invalid	0	-	0	-	0	-	0	-	0	-	0	-		
J9	TCLK low to boundary scan output high-Z	-	28	-	32	-	28	-	32	-	80	-	80	ns	
J10	TMS, TDI input data setup time to TCLK rise	3	-	3	-	3	-	3	-	15	-	15	-	ns	
J11	TMS, TDI input data hold time after TCLK rise	2	-	2	-	2	-	2	-	8	-	8	-	ns	
J12	TCLK low to TDO data valid	-	28	-	32	-	28	-	32	-	80	-	80	ns	
J13	TCLK low to TDO data invalid	0	-	0	-	0	-	0	-	0	-	0	-	ns	
J14	TCLK low to TDO high-Z	-	28	-	32	-	28	-	32	-	80	-	80	ns	



**Figure 34. Test Access Port timing**

## 7 Thermal attributes

### 7.1 Description

The tables in the following sections describe the thermal characteristics of the device.

#### NOTE

Junction temperature is a function of die size, on-chip power dissipation, package thermal resistance, mounting side (board) temperature, ambient temperature, air flow, power dissipation or other components on the board, and board thermal resistance.

### 7.2 Thermal characteristics

**Table 41. Thermal characteristics for 32-pin QFN and 48/64/100/144/176-pin LQFP package (continued)**

Rating	Conditions	Symbol	Package	Values						Unit
				S32K116	S32K118	S32K142	S32K144	S32K146	S32K148	
Thermal resistance, Junction to Package Top <sup>7</sup>	Natural Convection	$\Psi_{JT}$	32	1	NA	NA	NA	NA	NA	
				4	2	NA	NA	NA	NA	
				NA	2	2	2	2	NA	
				NA	NA	2	2	2	NA	
				NA	NA	NA	NA	2	1	
				NA	NA	NA	NA	NA	1	

1. Junction temperature is a function of die size, on-chip power dissipation, package thermal resistance, mounting site (board) temperature, ambient temperature, air flow, power dissipation of other components on the board, and board thermal resistance.
2. Per JEDEC JESD51-2 with natural convection for horizontally oriented board. Board meets JESD51-9 specification for 1s or 2s2p board, respectively.
3. Per JEDEC JESD51-6 with forced convection for horizontally oriented board. Board meets JESD51-9 specification for 1s or 2s2p board, respectively.
4. Thermal resistance between the die and the printed circuit board per JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.
5. Thermal resistance between the die and the case top surface as measured by the cold plate method (MIL SPEC-883 Method 1012.1).
6. Thermal resistance between the die and the solder pad on the bottom of the package. Interface resistance is ignored.
7. Thermal characterization parameter indicating the temperature difference between package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JT.

**Table 43. Revision History (continued)**

Rev. No.	Date	Substantial Changes
		<ul style="list-style-type: none"> <li>• Updated values for <math>V_{REFH}</math> and <math>V_{REFL}</math> to add reference to the section "voltage and current operating requirements" for Min and Max values</li> <li>• Updated footnote to Typ.</li> <li>• Removed footnote from RAS Analog source resistance</li> <li>• Updated figure: ADC input impedance equivalency diagram</li> <li>• In table: <b>12-bit ADC characteristics (2.7 V to 3 V)</b> (<math>V_{REFH} = V_{DDA}</math>, <math>V_{REFL} = V_{SS}</math>) <ul style="list-style-type: none"> <li>• Removed rows for <math>V_{TEMP\_S}</math> and <math>V_{TEMP25}</math></li> <li>• Updated footnote to Typ.</li> </ul> </li> <li>• In table: <b>12-bit ADC characteristics (3 V to 5.5 V)</b> (<math>V_{REFH} = V_{DDA}</math>, <math>V_{REFL} = V_{SS}</math>) <ul style="list-style-type: none"> <li>• Removed rows for <math>V_{TEMP\_S}</math> and <math>V_{TEMP25}</math></li> <li>• Removed number for TUE</li> <li>• Updated footnote to Typ.</li> </ul> </li> <li>• In table: <b>Comparator with 8-bit DAC electrical specifications</b> <ul style="list-style-type: none"> <li>• Updated Typ. of <math>I_{DDLS}</math> Supply current, Low-speed mode</li> <li>• Updated Typ. of <math>t_{DLB}</math> Propagation delay, Low-speed mode</li> <li>• Updated Typ. of <math>t_{DHSS}</math> Propagation delay, High-speed mode</li> <li>• Updated <math>t_{DLSS}</math> Propagation delay</li> <li>• Added row for <math>t_{DDAC}</math> Initialization and switching settling time</li> <li>• Updated footnote</li> </ul> </li> <li>• Updated section <b>LPSPI electrical specifications</b></li> <li>• Added section: <b>SAI electrical specifications</b></li> <li>• Updated section: <b>Ethernet AC specifications</b></li> <li>• Added section: <b>Clockout frequency</b></li> <li>• Added section: <b>Trace electrical specifications</b></li> <li>• Updated table: <b>Table 41</b> : Updated numbers for S32K142 and S32K148</li> <li>• Updated table: <b>Table 42</b> : Updated numbers for S32K148</li> <li>• Updated Document number for 32-pin QFN in topic <b>Obtaining package dimensions</b></li> </ul>
3	14 March 2017	<ul style="list-style-type: none"> <li>• In <b>Table 2</b> <ul style="list-style-type: none"> <li>• Updated min. value of <math>V_{DD\_OFF}</math></li> <li>• Added parameter <math>I_{INJSUM\_AF}</math></li> </ul> </li> <li>• Updated <b>Power mode transition operating behaviors</b></li> <li>• Updated <b>Power consumption</b></li> <li>• Updated footnote to <math>T_{SPLL\_LOCK}</math> in <b>SPLL electrical specifications</b></li> <li>• In <b>12-bit ADC electrical characteristics</b> <ul style="list-style-type: none"> <li>• Updated table: 12-bit ADC characteristics (2.7 V to 3 V) (<math>V_{REFH} = V_{DDA}</math>, <math>V_{REFL} = V_{SS}</math>) <ul style="list-style-type: none"> <li>• Added typ. value to <math>I_{DDA\_ADC}</math>, TUE, DNL, and INL</li> <li>• Added min. value to <math>SMPSTS</math></li> <li>• Removed footnote 'All the parameters in this table ...'</li> </ul> </li> <li>• Updated table: 12-bit ADC characteristics (3 V to 5.5 V) (<math>V_{REFH} = V_{DDA}</math>, <math>V_{REFL} = V_{SS}</math>) <ul style="list-style-type: none"> <li>• Added typ. value to <math>I_{DDA\_ADC}</math></li> <li>• Removed footnote 'All the parameters in this table ...'</li> </ul> </li> </ul> </li> <li>• In <b>Flash timing specifications — commands</b> updated Max. value of <math>t_{Vfykey}</math> to 33 <math>\mu</math>s</li> </ul>
4	02 June 2017	<ul style="list-style-type: none"> <li>• In section: <b>Block diagram</b>, added block diagram for S32K11x series.</li> <li>• Updated figure: <b>S32K1xx product series comparison</b>.</li> <li>• In section: <b>Selecting orderable part number</b>, added reference to attachment <b>S32K_Part_Numbers.xlsx</b>.</li> <li>• In section: <b>Ordering information</b> <ul style="list-style-type: none"> <li>• Updated figure: Ordering information.</li> </ul> </li> <li>• In <b>Table 1</b>,</li> </ul>

Table continues on the next page...

## Revision History

**Table 43. Revision History (continued)**

Rev. No.	Date	Substantial Changes
		<ul style="list-style-type: none"> <li>• Updated note 'All the limits defined ...'</li> <li>• Updated parameter '<math>I_{INJPAD\_DC\_ABS}</math>', '<math>V_{IN\_DC}</math>', '<math>I_{INJSUM\_DC\_ABS}</math>'</li> <li>• In <a href="#">Table 2</a>, <ul style="list-style-type: none"> <li>• Updated parameter <math>I_{INJPAD\_DC\_OP}</math> and <math>I_{INJSUM\_DC\_OP}</math>.</li> </ul> </li> <li>• In <a href="#">Table 5</a>, updated TBDs for <math>V_{LVR\_HYST}</math>, <math>V_{LVD\_HYST}</math>, and <math>V_{LVW\_HYST}</math></li> <li>• In <a href="#">Power mode transition operating behaviors</a>, <ul style="list-style-type: none"> <li>• Added <math>VLPR \rightarrow VLPS</math></li> <li>• Added <math>VLPS \rightarrow VLPR</math></li> <li>• Updated TBDs for <math>VLPS \rightarrow</math> Asynchronous DMA Wakeup, <math>STOP1 \rightarrow</math> Asynchronous DMA Wakeup, and <math>STOP2 \rightarrow</math> Asynchronous DMA Wakeup</li> </ul> </li> <li>• In <a href="#">Table 7</a>, updated the specifications for S32K144.</li> <li>• Updated the attachment <a href="#">S32K1xx_Power_Modes_Configuration.xlsx</a>.</li> <li>• In <a href="#">Table 15</a>, removed <math>C_{IN\_A}</math>.</li> <li>• In <a href="#">Table 17</a>, <ul style="list-style-type: none"> <li>• Updated specifacations for <math>g_{mXOSC}</math>.</li> <li>• Removed <math>I_{DDOSC}</math></li> </ul> </li> <li>• In <a href="#">Table 19</a>, <ul style="list-style-type: none"> <li>• Added parameter <math>\Delta F125</math>.</li> <li>• Removed <math>I_{DDFIRC}</math></li> </ul> </li> <li>• In <a href="#">Table 20</a>, <ul style="list-style-type: none"> <li>• Added parameter <math>\Delta F125</math>.</li> <li>• Removed <math>I_{DDSRIC}</math></li> </ul> </li> <li>• In <a href="#">Table 21</a>, removed <math>I_{LPO}</math></li> <li>• Updated section: <a href="#">Flash memory module (FTFC) electrical specifications</a></li> <li>• In section: <a href="#">12-bit ADC operating conditions</a>, <ul style="list-style-type: none"> <li>• Updated TBDs for <math>I_{DDA\_ADC}</math> and TUE in <a href="#">Table 28</a></li> <li>• Updated TBDs for <math>I_{DDA\_ADC}</math> and TUE in <a href="#">Table 29</a></li> </ul> </li> <li>• In section: <a href="#">QuadSPI AC specifications</a>, updated figure 'QuadSPI output timing (HyperRAM mode) diagram'.</li> <li>• In section: <a href="#">12-bit ADC operating conditions</a>, updated <a href="#">Table 27</a>.</li> <li>• In section: <a href="#">CMP with 8-bit DAC electrical specifications</a>, added note 'For comparator IN signals adjacent ...'</li> <li>• In table: <a href="#">Table 32</a>, minor update in footnote 6.</li> <li>• In table: <a href="#">Table 41</a>, updated specifications for S32K146.</li> </ul>
5	06 Dec 2017	<ul style="list-style-type: none"> <li>• Removed S32K148 from 'Caution'</li> <li>• Updated figure: <a href="#">S32K1xx product series comparison</a> for <ul style="list-style-type: none"> <li>• 'EEPROM emulated by FlexRAM' of S32K148 (Added content to footnote)</li> <li>• Added support for LIN protocol version 2.2 A</li> </ul> </li> <li>• In <a href="#">Absolute maximum ratings</a> : <ul style="list-style-type: none"> <li>• Added note 'Unless otherwise ...'</li> <li>• Added parameter 'Added note '<math>T_{ramp\_MCU}</math>'</li> <li>• Updated footnote for '<math>T_{ramp}</math>'</li> </ul> </li> <li>• In <a href="#">Voltage and current operating requirements</a> : <ul style="list-style-type: none"> <li>• Added footnote '<math>V_{DD}</math> and <math>V_{DDA}</math> must be shorted ...' against parameter '<math>V_{DD} - V_{DDA}</math>'</li> <li>• Updated footnote '<math>V_{DD}</math> and <math>V_{DDA}</math> must be shorted ...'</li> </ul> </li> <li>• In <a href="#">Power and ground pins</a> <ul style="list-style-type: none"> <li>• Added diagrams for 32-QFN and 48-LQFP and footnote below the diagrams.</li> <li>• Updated footnote '<math>V_{DD}</math> and <math>V_{DDA}</math> must be shorted ...'</li> </ul> </li> <li>• In <a href="#">Power mode transition operating behaviors</a> :</li> </ul>

*Table continues on the next page...*

## Revision History

**Table 43. Revision History**

Rev. No.	Date	Substantial Changes
		<ul style="list-style-type: none"><li>• Updated specs for <math>T_{JIT}</math> Cycle-to-Cycle jitter to 300 ps</li><li>• In <a href="#">QuadSPI AC specifications</a> :<ul style="list-style-type: none"><li>• Updated specs for <math>T_{iv}</math> Data Output In-Valid Time</li><li>• In figure 'QuadSPI output timing (SDR mode) diagram', marked Invalid area</li></ul></li><li>• In <a href="#">CMP with 8-bit DAC electrical specifications</a> :<ul style="list-style-type: none"><li>• Removed '(VAIO)' from description of <math>V_{HYST0}</math></li></ul></li><li>• In <a href="#">LPSPI electrical specifications</a> :<ul style="list-style-type: none"><li>• Added note 'Undefined' in figures 'LPSPI slave mode timing (CPHA = 0)' and 'LPSPI slave mode timing (CPHA = 1)'</li></ul></li></ul>